

**Search Notes**

Application/Control No.

10/781,414

Examiner

Con P. Tran

Applicant(s)/Patent under  
Reexamination

BAYON, PAUL WILLIAM

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner
381	94.5	6/15/2007	CPT
330	51	6/20/2007	CPT
381	94.1	6/20/2007	CPT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC/PLUS	6/13/2007	CPT
Xu Mei	6/18/2007	CPT
EAST (US-PGPUB, USPT, USOCR) - See Search History Printout	6/20/2007	CPT
Vivian Chin	6/20/2007	CPT